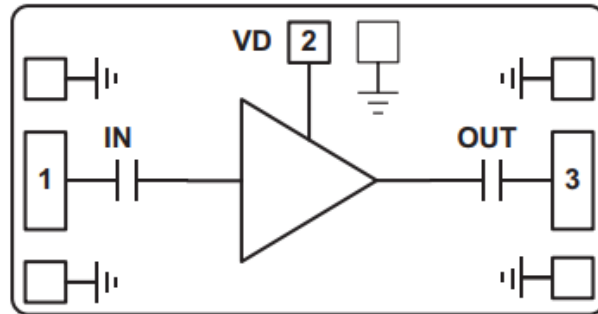


Features

- Noise Figure: 2.5dB
- Gain: 19dB, 3dB Positive Slope
- P1dB: +8.5dBm
- Biasing: +5V @ 11mA
- Impedance: 50Ω
- Die Size: 1.5 x 1.1 x 0.1 mm

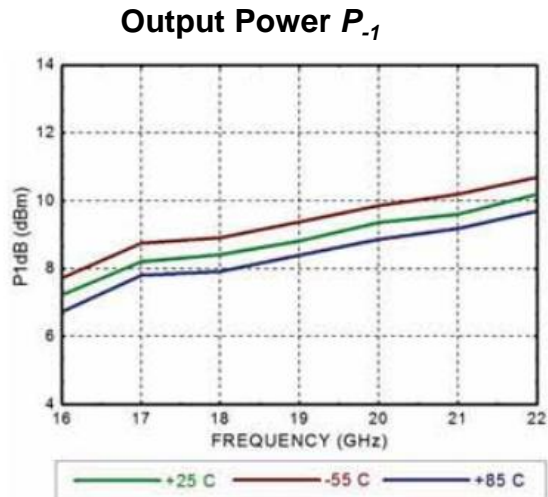
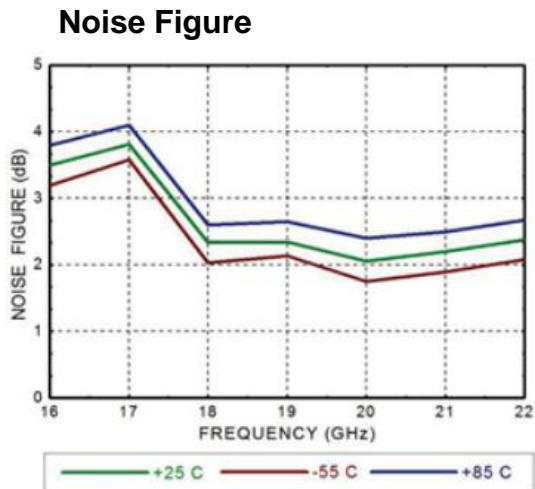
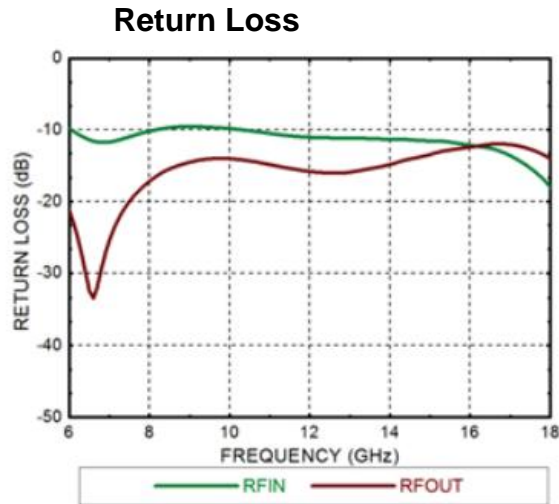
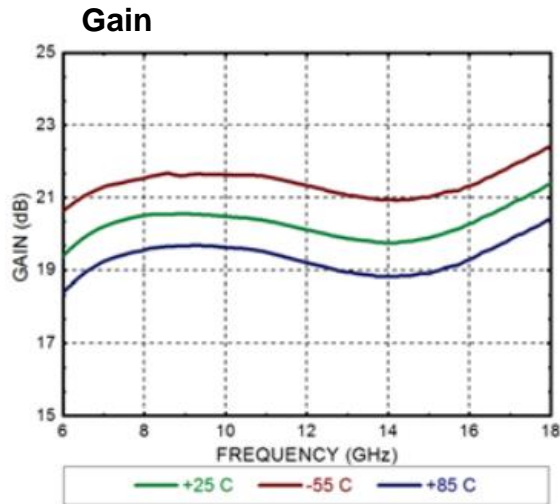
Typical Applications

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

Functional Block Diagram

Electrical Specifications

TA = +25°C, Vdd = +5V Idd = 11mA

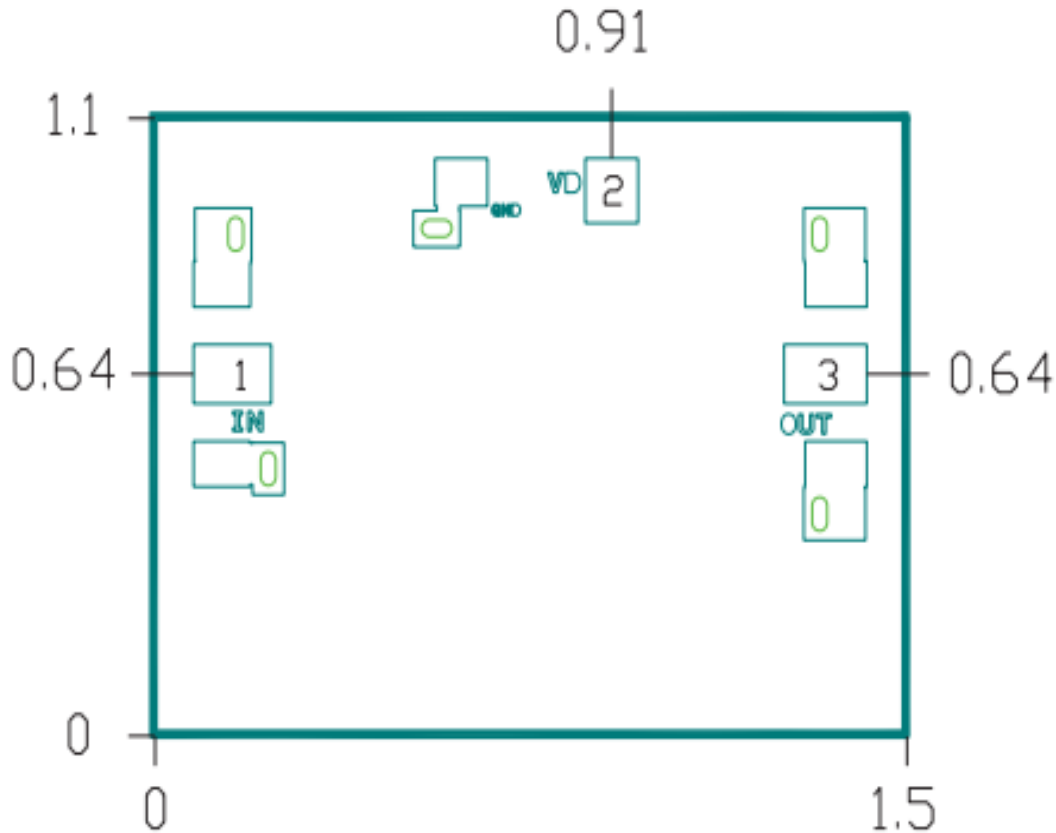
Parameters	Min.	Typ.	Max.	Units
Frequency	16 - 22			GHz
Gain		19		dB
Gain Flatness		±1.8		dB
Input Return Loss		8		dB
Output Return Loss		10		dB
Output 1dB Compression (P1dB)		8.5		dBm
Saturated Output Power (Psat)		10		dBm
Output Third Order Intercept (IP3)		17		dBm
Noise Figure		2.5		dB
Current	5	11	31	mA





Outline Drawing:

All Dimensions in mm

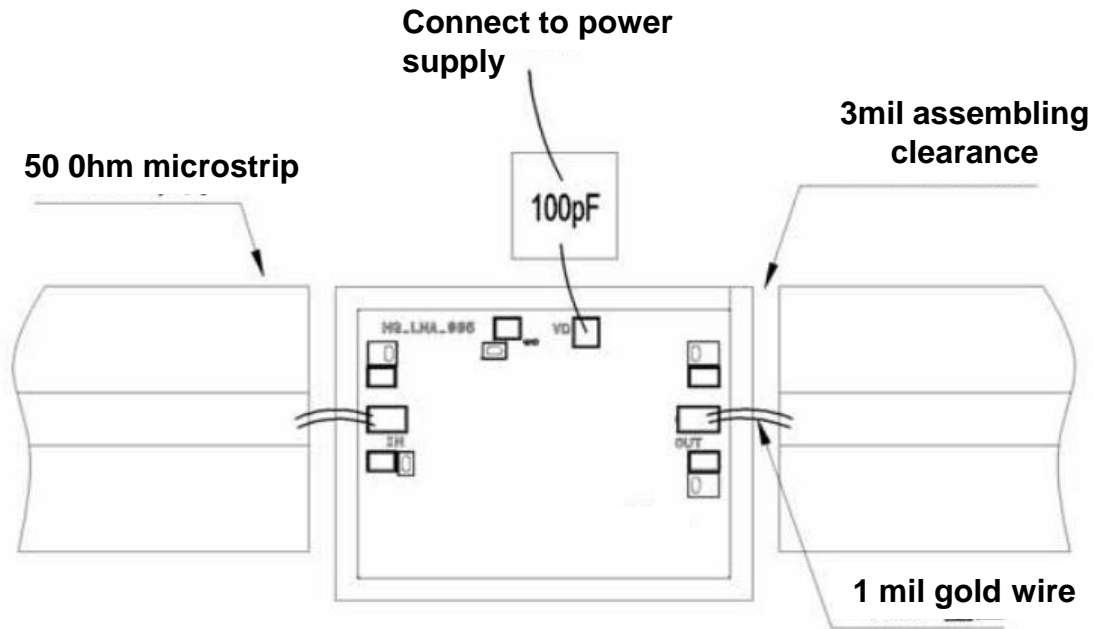


Pad Description

PAD	Function	Description
1	IN	Input AC coupling 50Ω Impedance.
2	VD	The pad provides the power supply voltage of the amplifier and needs to be externally connected with the 100pF bypass capacitor.
3	OUT	Output AC coupling 50Ω Impedance.
Die Bottom	GND	Die bottom must be connected to RF/DC ground.



Assembly Drawing



Notes:

1. Die thickness: 100um
2. Typical bond pad is 100*100 μm^2
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

Maximum Ratings:

1. Power supply voltage: +6V
2. RF input power: +18dBm
3. Storage temperature: -65°C to +175°C
4. Operating temperature: -55°C to +85°C